

Form PTO-1449
(REV. 1/06)US Dept. of Commerce
PATENT & TRADEMARK OFFICEATTY DOCKET NO.
117243APPLICATION NO.
10/690,270

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

APPLICANT(S)
Yuichi SHIMIZU et al.FILING DATE
October 22, 2003GROUP
2871

U.S. PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Name

FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation
M	1	JP-A-2000-094072	03/29/2002	Japan	X	X
L	2	JP-A-05-129333	05/25/1993	Japan	X	X
L	3	JP-A-04-022127	01/27/1992	Japan	X	
L	4	JP-A-2001-066638	03/16/2001	Japan	X	X

OTHER DOCUMENTS

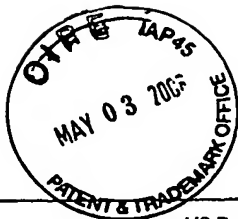
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER

DATE CONSIDERED

Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Date: April 12, 2006

Sheet 1 of 1Form PTO-1449
(REV. 1/06)US Dept. of Commerce
PATENT & TRADEMARK OFFICEATTY DOCKET NO.
117243APPLICATION NO.
10/690,270

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

APPLICANT(S)
Yuichi SHIMIZU et al.FILING DATE
October 22, 2003GROUP
2871

U.S. PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Name

FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation
AC	1	JP-A 2000-10120	01/14/2000	Japan	X	X
Y	2	JP-A 2002-57341	02/22/2002	Japan	X	x

OTHER DOCUMENTS

Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER

DATE CONSIDERED

Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Date: May 3, 2006